





OPA186, OPA2186, OPA4186

ZHCSPS9B - JUNE 2022 - REVISED DECEMBER 2022

OPAx186 精密、轨到轨输入和输出、24V、零漂移运算放大器

1 特性

高精度:

Texas

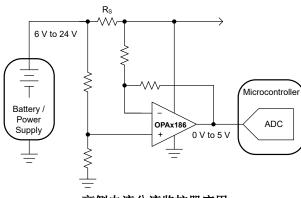
- 失调漂移:0.01 µ V/°C
- 低失调电压:**1**μV

INSTRUMENTS

- 低静态电流: 90 µA
- 出色的动态性能:
 - 增益带宽:750 kHz
 - 压摆率:0.35 V/µs
- 强大设计:
 - RFI/EMI 滤波输入
- 轨到轨输入/输出
- 电源电压范围:4.5V至24V
- 温度:-40°C 至+125°C

2 应用

- PC PSU 和游戏机单元
- 商用直流/直流
- 流量发送器
- 压力变送器
- 商用电池充电器
- 电表



高侧电流分流监控器应用

3 说明

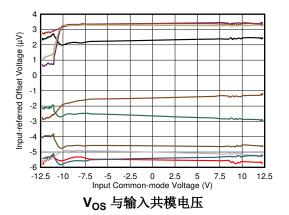
OPA186、OPA2186 和 OPA4186 (OPAx186) 是低功 耗、24V、轨到轨输入和输出、零漂移运算放大器。这 些运算放大器具有仅 10µV 的失调电压(最大值)和 0.04µV/℃的失调电压温漂(最大值),非常适合精密 仪表、信号测量和有源滤波应用。

低静态电流消耗 (90 µ A) 使 OPAx186 成为功率敏感型 应用 (例如电池供电仪表和便携式系统)的上佳选择。

此外,高共模架构以及低失调电压可实现正电源轨的高侧电流分流监控。这些器件还在运输、装卸和组装期间 提供强大的 ESD 保护。

器件信息					
器件型号	通道	封装 ⁽¹⁾			
OPA186	单通道	DBV(SOT-23,5)			
OPA2186	双通道	D (SOIC , 8)			
UPA2186	双迪坦	DDF(SOT-23,8)			
OPA4186	四通道	D (SOIC , 14)			

(1) 如需了解所有可用封装,请参阅数据表末尾的封装选项附录。



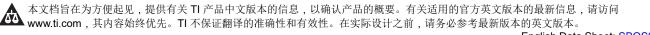




Table of Contents

1 特性	1
2 应用	. 1
3 说明	
4 Revision History	
5 Pin Configuration and Functions	
6 Specifications	5
6.1 Absolute Maximum Ratings	5
6.2 ESD Ratings	5
6.3 Recommended Operating Conditions	
6.4 Thermal Information: OPA186	
6.5 Thermal Information: OPA2186	6
6.6 Thermal Information: OPA4186	
6.7 Electrical Characteristics	
6.8 Typical Characteristics	9
7 Detailed Description	.17
7.1 Overview	17
7.2 Functional Block Diagram	17

7.3 Feature Description	18
7.4 Device Functional Modes	
8 Application and Implementation	<mark>23</mark>
8.1 Application Information	<mark>23</mark>
8.2 Typical Applications	25
8.3 Power Supply Recommendations	29
8.4 Layout	
9 Device and Documentation Support	32
9.1 Device Support	32
9.2 Documentation Support	
9.3 接收文档更新通知	
9.4 支持资源	32
9.5 Trademarks	
9.6 Electrostatic Discharge Caution	
9.7 术语表	
10 Mechanical, Packaging, and Orderable	
Information	

4 Revision History 注:以前版本的页码可能与当前版本的页码不同

Changes from Revision A (June 2022) to Revision B (November 2022)	Page
• 添加了 OPA186 和 OPA4186 器件及相关内容	1
Changed ESD Ratings table HBM value	5
Changed ESD Ratings table CDM value	5
Changes from Revision * (June 2022) to Revision A (September 2022)	Page
• 将 OPA2186 从预告信息 (预发布)更改为量产数据 (正在供货)	1



5 Pin Configuration and Functions

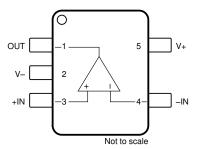


图 5-1. OPA186: DBV Package, 5-Pin SOT-23 (Top View)

表 5-1. Pin Functions: OPA186

PIN		ТҮРЕ	DESCRIPTION	
NAME	NO.	ITE	DESCRIPTION	
– IN	4	Input	Inverting input	
+IN	3	Input	Noninverting input	
OUT	1	Output	Output	
V -	2	Power	Negative (lowest) power supply	
V+	5	Power	Positive (highest) power supply	

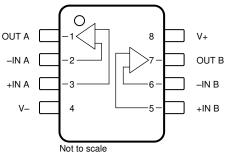
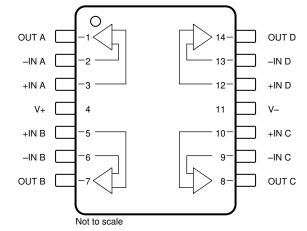




表 5-2. Pin Functions: OPA2186

PIN		ТҮРЕ	DESCRIPTION	
NAME	NO.	ITFE	DESCRIPTION	
– IN A	2	Input	Inverting input channel A	
+IN A	3	Input	Noninverting input channel A	
– IN B	6	Input	Inverting input channel B	
+IN B	5	Input	Noninverting input channel B	
OUT A	1	Output	Output channel A	
OUT B	7	Output	Output channel B	
V -	4	Power	Negative supply	
V+	8	Power	Positive supply	







PIN		TYPE	DESCRIPTION	
NAME	NO.		DESCRIPTION	
– IN A	2	Input	Inverting input channel A	
+IN A	3	Input	Noninverting input channel A	
– IN B	6	Input	Inverting input channel B	
+IN B	5	Input	Noninverting input channel B	
– IN C	9	Input	Inverting input channel C	
+IN C	10	Input	Noninverting input channel C	
– IN D	13	Input	Inverting input channel D	
+IN D	12	Input	Noninverting input channel D	
OUT A	1	Output	Output channel A	
OUT B	7	Output	Output channel B	
OUT C	8	Output	Output channel C	
OUT D	14	Output	Output channel D	
V -	11	Power	Negative supply	
V+	4	Power	Positive supply	

表 5-3. Pin Functions: OPA4186



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			MIN	MAX	UNIT
Vs	Supply voltage	e, V _S = (V+) - (V-)		26	V
		Common-mode	(V -) - 0.5	(V+) + 0.5	V
	Input voltage	Differential		(V+) - (V -) + 0.2	v
	Output short-o	sircuit ⁽²⁾	Contir	nuous	
TJ	Operating jun	ction temperature	-40	150	°C
T _{stg}	Storage temp	erature	-65	150	°C

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

(2) Short-circuit to ground, one amplifier per package.

6.2 ESD Ratings

		VALUE	UNIT
V	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±1000	V
V _(ESD)	Charged-device model (CDM), per JANSI/ESDA/JEDEC JS-002 ⁽²⁾	±500	v

(1) JEDEC document JEP155 states that 500-V HBM allows safemanufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safemanufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM MAX	UNIT
V _S Supply voltage	Single supply	4.5	24	V	
	Dual supply	±2.25	±12		
T _A	Specified temp	perature	- 40	125	°C



6.4 Thermal Information: OPA186

		OPA186	
	THERMAL METRIC ⁽¹⁾	DBV (SOT-23)	UNIT
		5 PINS	
R _{0JA}	Junction-to-ambient thermal resistance	166.8	°C/W
R _{0 JC(top)}	Junction-to-case (top) thermal resistance	62.2	°C/W
R _{0 JB}	Junction-to-board thermal resistance	38.6	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	12.1	°C/W
ΨЈВ	Junction-to-board characterization parameter	38.2	°C/W
R _{0 JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

6.5 Thermal Information: OPA2186

		OPA	OPA2186		
	THERMAL METRIC ⁽¹⁾	DDF (SOT-23)	D (SOIC)	UNIT	
		8 PINS	8 PINS		
R _{0 JA}	Junction-to-ambient thermal resistance	150.4	128.9	°C/W	
R _{0 JC(top)}	Junction-to-case (top) thermal resistance	85.6	69.2	°C/W	
R _{0 JB}	Junction-to-board thermal resistance	70.0	72.3	°C/W	
ΨJT	Junction-to-top characterization parameter	8.1	20.7	°C/W	
Ψ _{JB}	Junction-to-board characterization parameter	69.6	71.6	°C/W	
R _{0 JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	°C/W	

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

6.6 Thermal Information: OPA4186

		OPA4186	
	THERMAL METRIC ⁽¹⁾	D (SOIC)	UNIT
		14 PINS	
R _{0 JA}	Junction-to-ambient thermal resistance	84.3	°C/W
R n JC(top)	Junction-to-case (top) thermal resistance	37.4	°C/W
R _{0 JB}	Junction-to-board thermal resistance	41.4	°C/W
ΨJT	Junction-to-top characterization parameter	6.7	°C/W
ΨJB	Junction-to-board characterization parameter	40.8	°C/W
R _{0 JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

6.7 Electrical Characteristics

$at T = 25^{\circ}C V = 12.25 V t_{a} + 12 V D$	= 10 kO composited to $1/2 V = 1/2$	-1/ / 2 (uplace otherwise poted)
$a_{1}T_{A} - 25 C, v_{S} - \pm 2.25 v_{10} \pm 12 v, R_{1}$	= 10 k Ω connected to V _S / 2, V _{CM} = V _{OU}	$r = v_S / Z$ (unless otherwise noted)

	PARAMETER	TEST CONDITI	ONS	MIN	TYP	MAX	UNIT	
OFFSET	VOLTAGE							
V	Input offect voltage	OPA186, OPA2186 ⁽¹⁾			±1	±10		
V _{OS}	Input offset voltage	OPA4186 ⁽¹⁾		±6	±40	μV		
4)/ /4T	Input offect voltage drift	$T_{A} = -40^{\circ}C \text{ to } +125^{\circ}C^{(1)}$	OPA186, OPA2186		±0.01	±0.04		
dV _{OS} /dT	Input offset voltage drift	$T_A = -40 \ C \ 10 + 125 \ C \ 0$	OPA4186		±0.025	±0.1	μV/°C	
PSRR	Power-supply rejection	$T = 10^{\circ}$ to 10° (1)	OPA186, OPA2186		±0.02	±0.2		
PORK	ratio	$T_A = -40^{\circ}C$ to $+125^{\circ}C^{(1)}$	OPA4186		±0.08	±0.4	μ V/V	
INPUT B	IAS CURRENT							
					±5	±55	n A	
			$T_A = -40^{\circ}C \text{ to } +85^{\circ}C^{(1)}$			±550	pА	
I _B	Input bias current	V _S = ±12 V	$T_A = -40^{\circ}$ C to +125°C ⁽¹⁾ , OPA186, OPA2186		±4.8			
			T _A = −40°C to +125°C ⁽¹⁾ , OPA4186			±6.2		
			1		±10	±100	pА	
		T _A = −40°C to +85°C ⁽¹⁾		·		±1		
los	Input offset current		OPA186, OPA2186			±1.25	nA	
		$T_A = -40^{\circ}C$ to $+125^{\circ}C^{(1)}$	OPA4186			±3.8		
NOISE								
	Input voltage noise	f = 0.1 Hz to 10 Hz			125		nV _{RMS}	
e _N	Input voltage noise density	f = 1 kHz			40		nV/ √ Hz	
i _N	Input current noise	f = 1 kHz			120		fA/ √ Hz	
V _{CM}	Common-mode voltage			(V -) - 0.2		(V+) + 0.2	V	
			OPA2186	120	140	. ,		
		$V_{\rm S} = \pm 2.25 \text{V},$	OPA186	118	140			
	Common-mode rejection ratio	$(V -) - 0.1 < V_{CM} < (V+) + 0.1 V$	OPA4186	105	120			
		V _S = ±12 V,	OPA186, OPA2186	120	146			
		$(V -) - 0.1 < V_{CM} < (V+) + 0.1 V$	OPA4186	118	134			
CMRR		V _S = ±2.25 V,	OPA186, OPA2186	106	120		dB	
		$(V -) - 0.1 < V_{CM} < (V+) + 0.1 V,$	OPA4186	100	114			
		$T_A = -40^{\circ}C \text{ to } +125^{\circ}C^{(1)}$						
		$V_{S} = \pm 12 V,$ (V -) - 0.1 < V _{CM} < (V+) + 0.1 V,	OPA186, OPA2186	115	124			
		T _A = −40°C to +125°C ⁽¹⁾	OPA4186	115	124			
FREQUE	NCY RESPONSE							
GBW	Gain-bandwidth product				750		kHz	
SR	Slew rate	1-V step, G = 1			0.35		V/ μ s	
t _S	Settling time	To 0.1%, 1-V step, G = 1			7.5		μs	
	Overload recovery time	V _{IN} × gain > V _S			10		μs	
INPUT C	APACITANCE							
Z _{ID}	Differential				100 5		M Ω pF	
Z _{ICM}	Common-mode				50 2.5		GΩ∥pF	
OPEN-LO	OOP VOLTAGE GAIN							
		$V_{\rm S}$ = ±12 V, R _L = 10 kΩ,		123	148			
		$(V -) + 0.3 V < V_0 < (V+) - 0.3 V$	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C^{(1)}$	123	146			
		(. ,					dB	
A _{OL}	Open-loop voltage gain	$V_{\rm S} = \pm 12 \text{ V}, \text{ R}_{\rm L} = 2 \text{ k}\Omega,$		123	148		aв	



6.7 Electrical Characteristics (continued)

at T_A = 25°C, V_S = ± 2.25 V to ± 12 V, R_L = 10 k Ω connected to V_S / 2, V_{CM} = V_{OUT} = V_S / 2 (unless otherwise noted)

	PARAMETER	TEST CO	ONDITIONS	MIN TYP	MAX	UNIT
OUTPU	Т				I	
			No load	5	10	
			R _L = 10 k Ω	65		
		Positive rail	R _L = 2 k Ω	345	425	
	Voltage output swing from		$R_L = 10 \text{ k} \Omega$, $T_A = -40^{\circ}\text{C} \text{ to } +125^{\circ}\text{C}^{(1)}$	95	120	
	the rail		No load	5	10	mV
		Negative rail	R _L = 10 k Ω	30		
			R _L = 2 k Ω	90	120	
			$R_L = 10 k \Omega$, T _A = -40°C to +125°C ⁽¹⁾	35	50	
I _{SC}	Short-circuit current			±20		mA
C _{LOAD}	Capacitive load drive			See typical curve	s	
R ₀	Open-loop output impedance			See typical curve	s	
POWER	RSUPPLY				I	
1.	Quiescent current per	V _S = ±2.25 V to ±12 V		90	130	μA
l _Q	amplifier	VS - 12.20 V 10 112 V	$T_{A} = -40^{\circ}C \text{ to } +125^{\circ}C^{(1)}$		150	μΑ

(1) Specification established from device population bench system measurements across multiple lots.



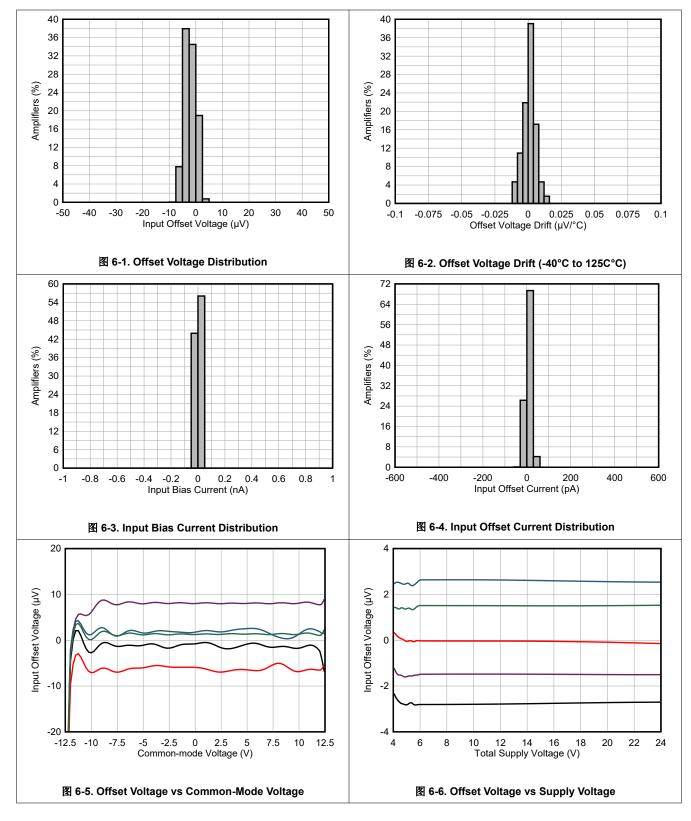
6.8 Typical Characteristics

表 6-1. Typical Characteristic Graphs	表 6-1.	Typical	Characteristic	Graphs
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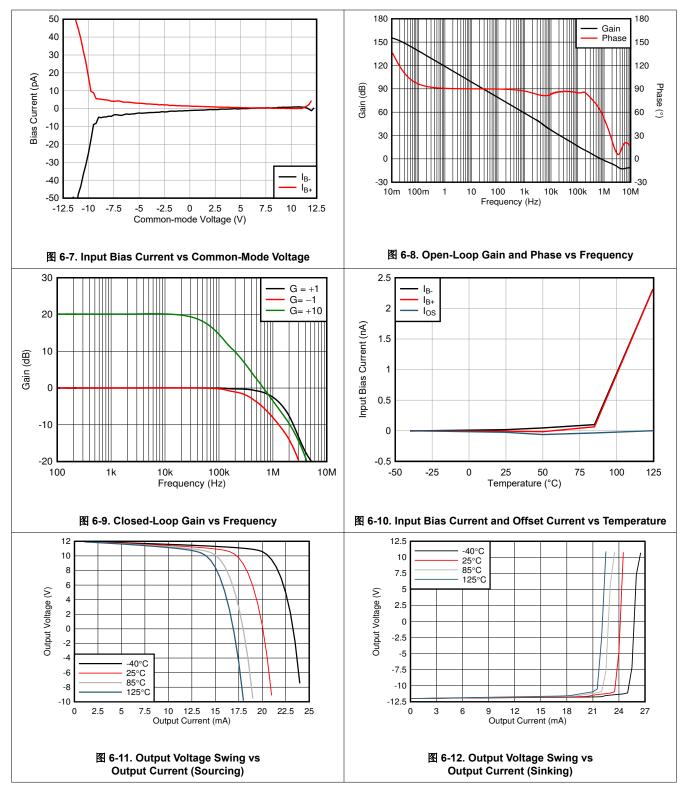
DESCRIPTION	FIGURE
Offset Voltage Distribution	图 6-1
Offset Voltage Drift (-40°C to +125C°C)	图 6-2
Input Bias Current Distribution	图 6-3
Input Offset Current Distribution	图 6-4
Offset Voltage vs Common-Mode Voltage	图 6-5
Offset Voltage vs Supply Voltage	图 6-6
Input Bias Current vs Common-Mode Voltage	图 6-7
Open-Loop Gain and Phase vs Frequency	图 6-8
Closed-Loop Gain vs Frequency	图 6-9
Input Bias Current and Offset Current vs Temperature	图 6-10
Output Voltage Swing vs Output Current (Sourcing)	图 6-11
Output Voltage Swing vs Output Current (Sinking)	图 6-12
CMRR and PSRR vs Frequency	图 6-13
CMRR vs Temperature	图 6-14
PSRR vs Temperature	图 6-15
0.1-Hz to 10-Hz Voltage Noise	图 6-16
Input Voltage Noise Spectral Density vs Frequency	图 6-17
THD+N vs Frequency	图 6-18
THD+N vs Output Amplitude	图 6-19
Quiescent Current vs Supply Voltage	图 6-20
Quiescent Current vs Temperature	图 6-21
Open-Loop Gain vs Temperature (10 k Ω)	图 6-22
Open-Loop Gain vs Temperature (2 k Ω)	图 6-23
Open-Loop Output Impedance vs Frequency	图 6-24
Small-Signal Overshoot vs Capacitive Load (Gain = - 1, 10-mV step)	图 6-25
Small-Signal Overshoot vs Capacitive Load (Gain = 1, 10-mV step)	图 6-26
No Phase Reversal	图 6-27
Positive Overload Recovery	图 6-28
Negative Overload Recovery	图 6-29
Small-Signal Step Response (Gain = 1, 10-mV step)	图 6-30
Small-Signal Step Response (Gain = -1, 10-mV step)	图 6-31
Large-Signal Step Response (Gain = 1, 10-V step)	图 6-32
Large-Signal Step Response (Gain = - 1, 10-V step)	图 6-33
Phase Margin vs Capacitive Load	图 6-34
Settling Time (1-V Step, 0.1% Settling)	图 6-35
Short Circuit Current vs Temperature	图 6-36
Maximum Output Voltage vs Frequency	图 6-37
EMIRR vs Frequency	图 6-38
Channel Separation	图 6-39

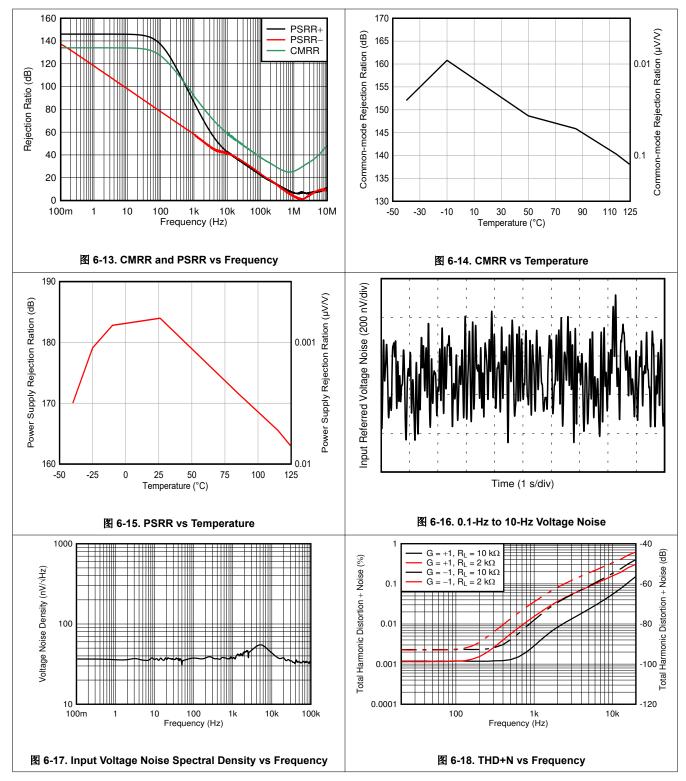
6.8 Typical Characteristics

at T_A = 25°C, V_S = ±12 V, V_{CM} = V_S / 2, R_L = 10 k $^{\Omega}$ (unless otherwise noted)

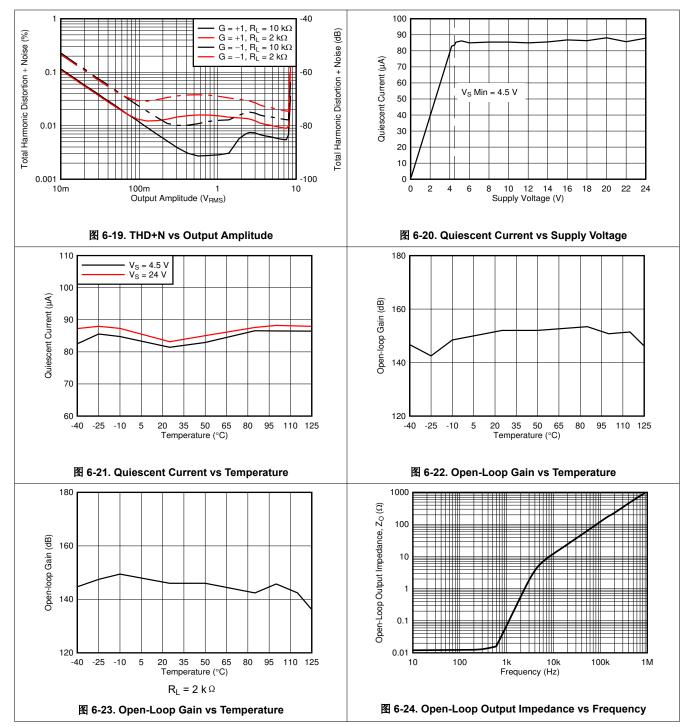




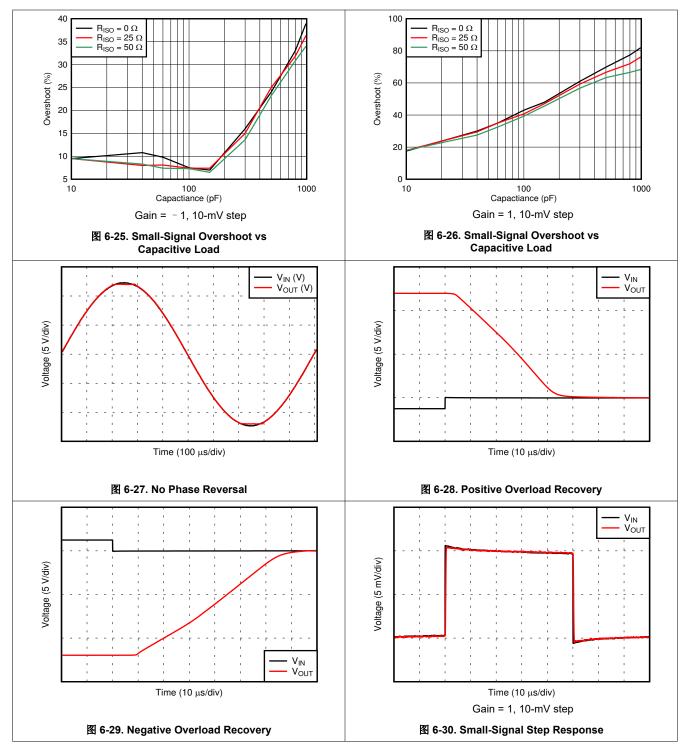




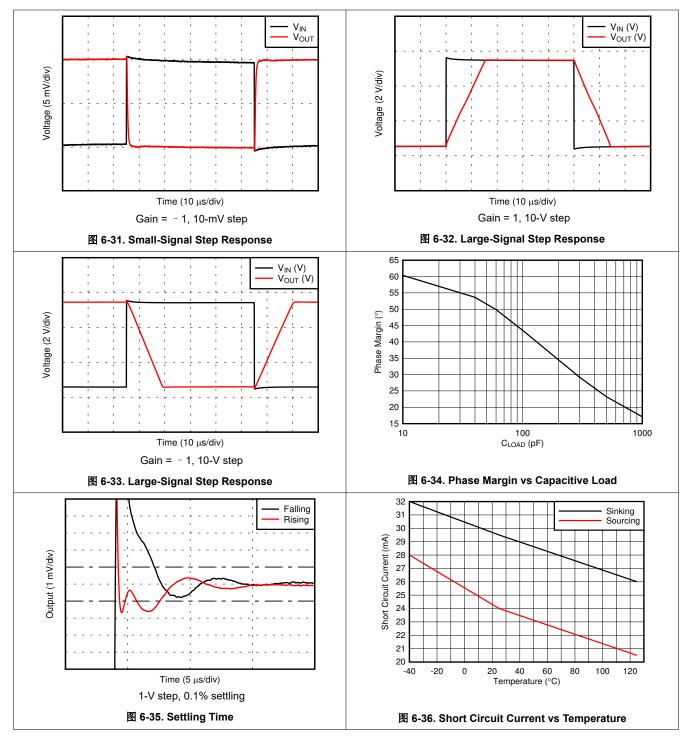






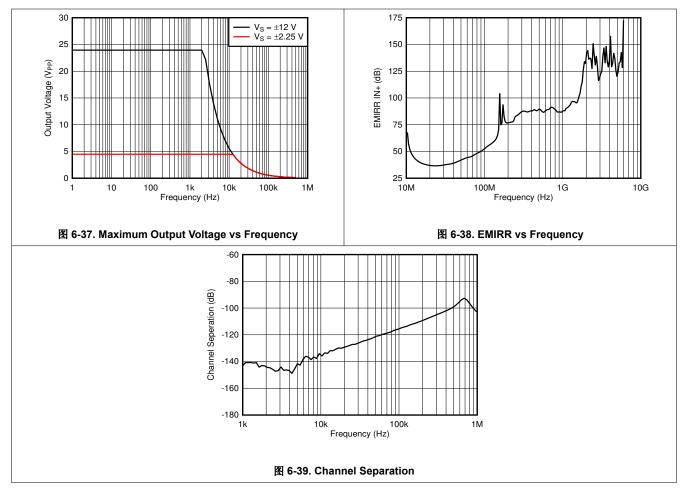








at T_A = 25°C, V_S = ±12 V, V_{CM} = V_S / 2, R_L = 10 k $^{\Omega}$ (unless otherwise noted)





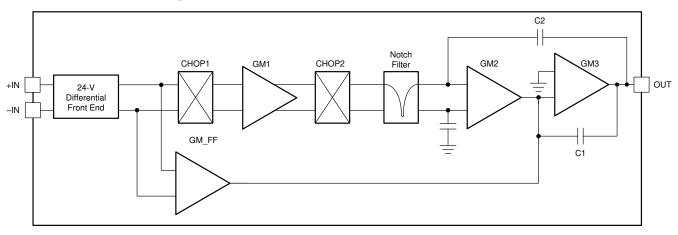
7 Detailed Description

7.1 Overview

The OPAx186 operational amplifier combines precision offset and drift with excellent overall performance, making the device a great choice for a wide variety of precision applications. The precision offset drift of only 0.01 μ V/°C provides stability over the entire operating temperature range of -40°C to +125°C. In addition, this device offers excellent linear performance with high CMRR, PSRR, and A_{OL}. As with all amplifiers, applications with noisy or high-impedance power supplies require decoupling capacitors close to the device pins. In most cases, 0.1- μ F capacitors are adequate. For details and a layout example, see $\ddagger 8.4$.

The OPAx186 is part of a family of zero-drift, MUX-friendly, rail-to-rail output operational amplifiers. This device operates from 4.5 V to 24 V, is unity-gain stable, and is designed for a wide range of general-purpose and precision applications. The zero-drift architecture provides ultra-low input offset voltage and near-zero input offset voltage drift over temperature and time. This choice of architecture also offers outstanding ac performance, such as ultra-low broadband noise, zero flicker noise, and outstanding distortion performance when operating at less than the chopper frequency.

The following section shows a representation of the proprietary OPAx186 architecture.



7.2 Functional Block Diagram



7.3 Feature Description

The OPAx186 operational amplifier has several integrated features to help maintain a high level of precision through a variety of applications. These include a rail-to-rail inputs, phase-reversal protection, input bias current clock feedthrough, EMI rejection, electrical overstress protection and MUX-friendly Inputs.

7.3.1 Rail-to-Rail Inputs

Unlike many chopper amplifiers, the OPAx186 has rail-to-rail inputs that allow the input common-mode voltage to not only reach, but exceed the supply voltages by 200 mV. This configuration simplifies power-supply requirements by not requiring headroom over the input signal range.

The OPAx186 is specified for operation from 4.5 V to 24 V (± 2.25 V to ± 12 V) with rail-to-rail inputs. Many specifications apply from -40° C to $\pm 125^{\circ}$ C.

7.3.2 Phase-Reversal Protection

The OPAx186 has internal phase-reversal protection. Some op amps exhibit a phase reversal when the input is driven beyond the linear common-mode range. This condition is most often encountered in noninverting circuits when the input is driven beyond the specified common-mode voltage range, causing the output to reverse into the opposite rail. The OPAx186 input prevents phase reversal with excessive common-mode voltage. Instead, the output limits into the appropriate rail. [X] 7-1 shows this performance.

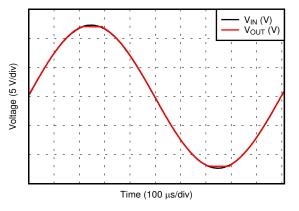


图 7-1. No Phase Reversal

7.3.3 Input Bias Current Clock Feedthrough

Zero-drift amplifiers such as the OPAx186 use a switching architecture on the inputs to correct for the intrinsic offset and drift of the amplifier. Charge injection from the integrated switches on the inputs can introduce short transients in the input bias current of the amplifier. The extremely short duration of these pulses prevents the pulses from amplifying; however, the pulses can be coupled to the output of the amplifier through the feedback network. The most effective method to prevent transients in the input bias current from producing additional noise at the amplifier output is to use a low-pass filter, such as an RC network.



7.3.4 EMI Rejection

The OPAx186 uses integrated electromagnetic interference (EMI) filtering to reduce the effects of EMI interference from sources such as wireless communications and densely-populated boards with a mix of analog signal chain and digital components. EMI immunity can be improved with circuit design techniques; the OPAx186 benefits from these design improvements. Texas Instruments has developed the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10 MHz to 6 GHz. 图 7-2 shows the results of this testing on the OPAx186. 表 7-1 lists the EMIRR +IN values for the OPAx186 at particular frequencies commonly encountered in real-world applications. 表 7-1 lists applications that can be centered on or operated near the particular frequency shown. See also the *EMI Rejection Ratio of Operational Amplifiers* application report, available for download from www.ti.com.

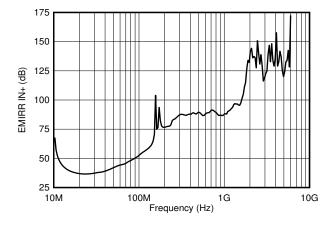




表 7-1. OPAx186 EMIRR IN+ for Frequencies of Interest

FREQUENCY	APPLICATION AND ALLOCATION						
400 MHz	Mobile radio, mobile satellite, space operation, weather, radar, ultra-high frequency (UHF) applications						
900 MHz	900 MHz Global system for mobile communications (GSM) applications, radio communication, navigation, GPS (to 1.6 GHz), GSM, aeronautical mobile, UHF applications						
1.8 GHz	GSM applications, mobile personal communications, broadband, satellite, L-band (1 GHz to 2 GHz)	69.1 dB					
2.4 GHz	802.11b, 802.11g, 802.11n, Bluetooth [®] , mobile personal communications, industrial, scientific and medical (ISM) radio band, amateur radio and satellite, S-band (2 GHz to 4 GHz)	88.9 dB					
3.6 GHz	Radiolocation, aero communication and navigation, satellite, mobile, S-band	82.5 dB					
5 GHz	802.11a, 802.11n, aero communication and navigation, mobile communication, space and satellite operation, C-band (4 GHz to 8 GHz)	95.5 dB					



The electromagnetic interference (EMI) rejection ratio, or EMIRR, describes the EMI immunity of operational amplifiers. An adverse effect that is common to many op amps is a change in the offset voltage as a result of RF signal rectification. An op amp that is more efficient at rejecting this change in offset as a result of EMI has a higher EMIRR and is quantified by a decibel value. Measuring EMIRR can be performed in many ways, but this section provides the EMIRR +IN, which specifically describes the EMIRR performance when the RF signal is applied to the noninverting input pin of the op amp. In general, only the noninverting input is tested for EMIRR for the following three reasons:

- Op amp input pins are known to be the most sensitive to EMI, and typically rectify RF signals better than the supply or output pins.
- The noninverting and inverting op amp inputs have symmetrical physical layouts and exhibit nearly matching EMIRR performance
- EMIRR is more simple to measure on noninverting pins than on other pins because the noninverting input terminal can be isolated on a PCB. This isolation allows the RF signal to be applied directly to the noninverting input terminal with no complex interactions from other components or connecting PCB traces.

High-frequency signals conducted or radiated to any pin of the operational amplifier can result in adverse effects, as there is insufficient amplifier loop gain to correct for signals with spectral content outside the bandwidth. Conducted or radiated EMI on inputs, power supply, or output can result in unexpected dc offsets, transient voltages, or other unknown behavior. Take care to properly shield and isolate sensitive analog nodes from noisy radio signals and digital clocks and interfaces.

7.3.4.1 EMIRR +IN Test Configuration

[**7-3** shows the circuit configuration for testing the EMIRR +IN. An RF source is connected to the op-amp noninverting input pin using a transmission line. The op amp is configured in a unity-gain buffer topology with the output connected to a low-pass filter (LPF) and a digital multimeter (DMM). A large impedance mismatch at the op amp input causes a voltage reflection; however, this effect is characterized and accounted for when determining the EMIRR IN+. The multimeter samples and measures the resulting dc offset voltage. The LPF isolates the multimeter from residual RF signals that can interfere with multimeter accuracy.

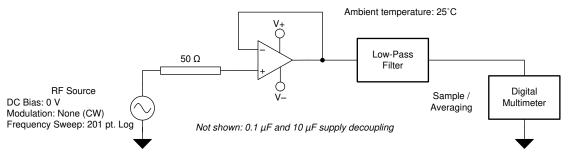


图 7-3. EMIRR +IN Test Configuration





7.3.5 Electrical Overstress

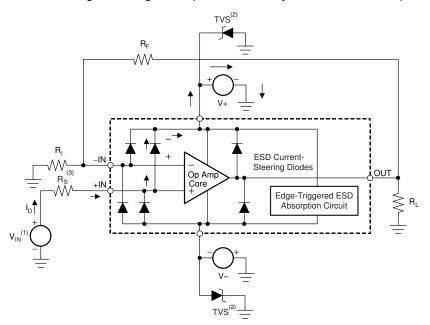
Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress. These questions tend to focus on the device inputs, but can involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits to protect from accidental ESD events both before and during product assembly.

Having a good understanding of this basic ESD circuitry and the relevance to an electrical overstress event is helpful. [8] 7-4 shows an illustration of the ESD circuits contained in the OPAx186 (indicated by the dashed line area). The ESD protection circuitry involves several current-steering diodes connected from the input and output pins and routed back to the internal power-supply lines, where the diodes meet at an absorption device internal to the operational amplifier. This protection circuitry is intended to remain inactive during normal circuit operation.

An ESD event produces a short-duration, high-voltage pulse that is transformed into a short-duration, highcurrent pulse while discharging through a semiconductor device. The ESD protection circuits are designed to provide a current path around the operational amplifier core to prevent damage. The energy absorbed by the protection circuitry is then dissipated as heat.

When an ESD voltage develops across two or more amplifier device pins, current flows through one or more steering diodes. Depending on the path that the current takes, the absorption device can activate. The absorption device has a trigger or threshold voltage that is greater than the normal operating voltage of the OPAx186, but less than the device breakdown voltage level. When this threshold is exceeded, the absorption device quickly activates and clamps the voltage across the supply rails to a safe level.

Intended to remain inactive, and do not become involved in the application circuit operation. However, circumstances can arise where an applied voltage exceeds the operating voltage range of a given pin. If this condition occurs, there is a risk that some internal ESD protection circuits are biased on and conduct current. Any such current flow occurs through steering-diode paths and rarely involves the absorption device.



(1) V_{IN} = (V+) + 500 mV

(2) TVS: 26 V > $V_{\text{TVSBR (min)}}$ > V+, where $V_{\text{TVSBR (min)}}$ is the minimum specified value for the transient voltage suppressor breakdown voltage.

(3) Suggested value is approximately 5 k Ω in example overvoltage condition.

图 7-4. Equivalent Internal ESD Circuitry Relative to a Typical Circuit Application



 \mathbb{X} 7-4 shows a specific example where the input voltage (V_{IN}) exceeds the positive supply voltage (V+) by 500 mV or more. Much of what happens in the circuit depends on the supply characteristics. If V+ can sink the current, one of the upper input steering diodes conducts and directs current to +V_S. Excessively high current levels can flow with increasingly higher V_{IN}. As a result, the data sheet specifications recommend that applications limit the input current to 10 mA.

If the supply is not capable of sinking the current, V_{IN} can begin sourcing current to the operational amplifier, and then take over as the source of positive supply voltage. The danger in this case is that the voltage can rise to levels that exceed the operational amplifier absolute maximum ratings.

Another common question involves what happens to the amplifier if an input signal is applied to the input while the power supplies V+ or V - are at 0 V. Again, this question depends on the supply characteristic while at 0 V, or at a level below the input signal amplitude. If the supplies appear as high impedance, then the operational amplifier supply current can be supplied by the input source through the current-steering diodes. This state is not a normal biasing condition for the amplifier and can result in specification degradation or abnormal operation. If the supplies are low impedance, then the current through the steering diodes can become quite high. The current level depends on the ability of the input source to deliver current, and any resistance in the input path.

If there is any uncertainty about the ability of the supply to absorb this current, add external Zener diodes to the supply pins; see also 8 7-4. The Zener voltage must be selected such that the diode does not turn on during normal operation. However, the Zener voltage must be low enough so that the Zener diode conducts if the supply pin begins to rise above the safe operating supply voltage level.

7.3.6 MUX-Friendly Inputs

The OPAx186 features a proprietary input stage design that allows an input differential voltage to be applied while maintaining high input impedance. Typically, high-voltage CMOS or bipolar-junction input amplifiers feature antiparallel diodes that protect input transistors from large V_{GS} voltages that can exceed the semiconductor process maximum and permanently damage the device. Large V_{GS} voltages can be forced when applying a large input step, switching between channels, or attempting to use the amplifier as a comparator.

The OPAx186 solves these problems with a switched-input technique that prevents large input bias currents when large differential voltages are applied. This input architecture addresses many issues seen in switched or multiplexed applications, where large disruptions to RC filtering networks are caused by fast switching between large potentials. The OPAx186 offers outstanding settling performance as a result of these design innovations and built-in slew-rate boost and wide bandwidth. The OPAx186 can also be used as a comparator. Differential and common-mode input ranges still apply.

7.4 Device Functional Modes

The OPAx186 has a single functional mode, and is operational when the power-supply voltage is greater than $4.5 \text{ V} (\pm 2.25 \text{ V})$. The maximum power supply voltage for the OPAx186 is 24 V ($\pm 12 \text{ V}$).



8 Application and Implementation

备注

以下应用部分中的信息不属于 TI 器件规格的范围, TI 不担保其准确性和完整性。TI 的客 户应负责确定器件是否适用于其应用。客户应验证并测试其设计,以确保系统功能。

8.1 Application Information

The OPAx186 operational amplifier combines precision offset and drift with excellent overall performance, making the device an excellent choice for many precision applications. The precision offset drift of only 0.01 μ V/°C provides stability over the entire temperature range. In addition, the device pairs excellent CMRR, PSRR, and A_{OL} dc performance with outstanding low-noise operation. As with all amplifiers, applications with noisy or high-impedance power supplies require decoupling capacitors close to the device pins. In most cases, 0.1- μ F capacitors are adequate.

8.1.1 Basic Noise Calculations

Low-noise circuit design requires careful analysis of all noise sources. In many cases, external noise sources can dominate; consider the effect of source resistance on overall op-amp noise performance. Total noise of the circuit is the root-sum-square combination of all noise components.

The resistive portion of the source impedance produces thermal noise proportional to the square root of the resistance. The source impedance is usually fixed; consequently, select op amp and the feedback resistors that minimize the respective contributions to the total noise.

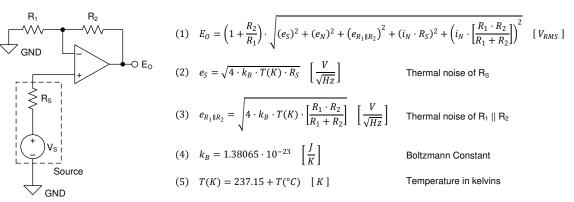
 \mathbb{R} 8-1 shows both noninverting (*A*) and inverting (*B*) op-amp circuit configurations with gain. In circuit configurations with gain, the feedback network resistors also contribute noise. In general, the current noise of the op amp reacts with the feedback resistors to create additional noise components. However, the extremely low current noise of the OPAx186 means that the current noise contribution can be ignored.

The feedback resistor values can generally be chosen to make these noise sources negligible. Low impedance feedback resistors load the output of the amplifier. The equations for total noise are shown for both configurations.



(A) Noise in Noninverting Gain Configuration

Noise at the output is given as E_o, where



(B) Noise in Inverting Gain Configuration

Noise at the output is given as E₀, where

$$\begin{array}{c} \mathsf{R}_{1} & \mathsf{R}_{2} \\ \mathsf{R}_{S} & \mathsf{R}_{1} & \mathsf{R}_{1} & \mathsf{R}_{2} \\ \mathsf{R}_{1} & \mathsf{R}_{1} & \mathsf{R}_{2} \\ \mathsf{R}_{1} & \mathsf{R}_{2} \\ \mathsf{R}$$

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Where e_n is the voltage noise spectral density of the amplifier. For the OPAx186 operational amplifier, $e_n = 38 \text{ nV} / \sqrt{\text{Hz}}$ at 1 kHz. NOTE: For additional resources on noise calculations, visit *TI Precision Labs*.

图 8-1. Noise Calculation in Gain Configurations



8.2 Typical Applications

8.2.1 High-Side Current Sensing

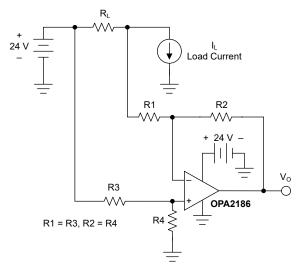


图 8-2. High-Side Current Monitor

8.2.1.1 Design Requirements

A common systems requirement is to monitor the current being delivered to a load. Monitoring makes sure that normal current levels are being maintained, and also provides an alert if an overcurrent condition occurs.

Fortunately, a relatively simple current monitor solution can be achieved using a precision rail-to-rail input/output op amp such as the OPAx186. This device has an input common-mode voltage (V_{CM}) range that extends 200 mV beyond each power supply rail allowing for operation at the supply rail.

The OPAx186 is configured as a difference amplifier with a predetermined gain. The difference amplifier inputs are connected across a sense resistor through which the load current flows. The sense resistor can be connected to the high side or low side of the circuit through which the load current flows. Commonly, high-side current sensing is applied. 🛛 8-2 shows an applicable OPAx186 configuration. Low-side current sensing can be applied as well if the sense resistor can be placed between the load and ground.

Use the following parameters for this design example:

- Single supply: 24 V
- Linear output voltage range: 0.3 V to 3.3 V
- Load current, I_L: 1 A to 11 A

The following design details and equations can be used to reconfigure this design for different output voltage ranges and current loads.



8.2.1.2 Detailed Design Procedure

Designing a high-side current monitor circuit is straightforward, provided that the amplifier electrical characteristics are carefully considered so that linear operation is maintained. Other additional characteristics, such as the input voltage range of the analog to digital converter (ADC) that follows the current monitor stage, must also be considered when configuring the system.

For example, consider the design of a OPAx186 high-side current monitor with an output voltage range set to be compatible with the input of an ADC with an input range of 3.3 V, such as one integrated in a microcontroller. The full-scale input range of this converter is 0 V to 3.3 V. Although the OPAx186 is specified as a rail-to-rail input/output (RRIO) amplifier, the linear output operating range (like all amplifiers) does not quite extend all the way to the supply rails. This linear operating range must be considered.

In this design example, the OPAx186 is powered by 24 V; therefore, the device is easily capable of providing the 3.3-V positive level; or even more, if the ADC has a wider input range. However, because the OPAx186 output does not swing completely to 0 V, the specified lower swing limit must be observed in the design.

The best measure of an op-amp linear output voltage range comes from the open-loop voltage gain (A_{OL}) specification listed in the *Electrical Characteristics* table. The A_{OL} test conditions specify a linear swing range 300 mV from each supply rail ($R_L = 10 \text{ k}\Omega$). Therefore, the linear swing limit on the low end (V_{oMIN}) is 300 mV, and 3.3 V is the V_{oMAX} limit, thus yielding an 11:1 V_{oMAX} to V_{oMIN} ratio. This ratio proves important in determining the difference amplifier operating parameters.

A nominal load current (I_L) of 10 A is used in this example. In most applications, however, the ability to monitor current levels far less than 10 A is useful. This situation is where the 11:1 V_{oMAX} to V_{oMIN} ratio is crucial. If 11 A is set as the maximum current, this current must correspond to a 3.3-V output. Using the 11:1 ratio, the minimum current of 1 A corresponds to 300 mV.

Selection of current sense resistor R_S comes down to how much voltage drop can be tolerated at maximum current and the permissible power loss or dissipation. A good compromise for a 10-A sense application is an R_S of 10 m Ω . That value results in a power dissipation of 1 W, and a 0.1-V drop at 10 A.

Next, determine the gain of the OPAx186 difference amplifier circuit. The maximum current of 11 A flowing through a 10-m Ω sense resistor results in 110 mV across the resistor. That voltage appears as a differential voltage, V_R, that is applied across the OPAx186 difference amplifier circuit inputs:

$$V_{\rm S} = I_{\rm L} * R_{\rm S}$$

 $V_{\rm S} = 11 \,{\rm A} * 10 \,{\rm m}\Omega = 110 \,{\rm mV}$ (1)

The OPAx186 required voltage gain is determined from:

$$G_{A} = \frac{V_{OMAX}}{V_{S}}$$

$$G_{A} = \frac{3.3 V}{0.11 V} = 30 \frac{V}{V}$$
(2)

Now, checking the V_{oMIN} using $I_L = 1 A$:

* D

* 1

$$V_{OMIN} = G_A \quad V_{SMIN} \quad H_S$$
$$V_{OMIN} = 30 \frac{V}{V} * 1 \text{ A } * 10 \text{ m}\Omega = 300 \text{ mV}$$

٠,

(3)



[8] 8-3 shows the complete OPAx186 high-side current monitor. The circuit is capable of monitoring a current range of < 1 A to 11 A, with a V_{CM} very close to the 24-V supply voltage.

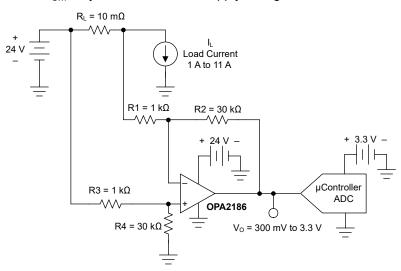


图 8-3. OPAx186 Configured as a High-Side Current Monitor

In this example, the OPAx186 output voltage is intentionally limited to 3.3 V. However, because of the 24-V supply, the output voltage can be much higher to allow for a higher-voltage data converter with a higher dynamic range.

The circuit in 🛛 8-3 was checked using the TINA Spice circuit simulation tool to verify the correct operation of the OPAx186 high-side current monitor. The simulation results are seen in 🖾 8-4. The performance is exactly as expected. Upon careful inspection of the plots, one possible surprise is that V_O continues towards zero as the sense current drops below 1 A, where V_O is 300 mV and less.

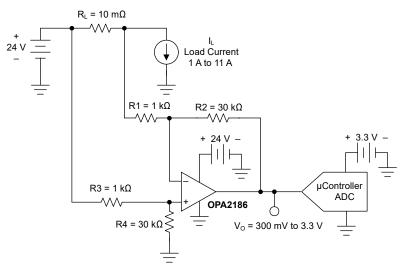


图 8-4. OPAx186 High-Side Current-Monitor Simulation Schematic

The OPAx186 output, as well as other CMOS output amplifiers, often swing closer to 0 V than the linear output parameters suggest. The voltage output swing, V_0 (see the *Electrical Characteristics* table), is not an indication of the linear output range, but rather how close the output can move towards the supply rail. In that region, the amplifier output approaches saturation, and the amplifier ceases to operate linearly. Thus, in the current-monitor application, the current-measurement capability can continue to much less than the 300-mV output level. However, keep in mind that the linearity errors are becoming large.

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Lastly, some notes about maximizing the high-side current monitor performance:

- All resistor values are critical for accurate gain results. Match resistor pairs of [R1 and R3] and [R2 and R4] as closely as possible to minimize common-mode mismatch error. Use a 0.1% tolerance, or better. Often, selecting two adjacent resistors on a reel provides close matching compared to random selection.
- Keep the closed-loop gain, G_A, of the OPAx186 difference amplifier set to a reasonable value to reduce gain error and maximize bandwidth. A G_A of 30 V/V is used in the example.
- Although current monitoring is often used for monitoring dc supply currents, ac current can also be monitored.
 The 3-dB bandwidth, or upper cutoff frequency, of the circuit is:

$$f_{H} = \frac{GBW}{Noise \ Gain}$$
(4)

where

- GBW is the amplifier unity gain bandwidth; 750 kHz for the OPAx186.
- 方程式 5 shows that the noise gain is equal to the gain as seen looking into the op-amp noninverting input, as shown in .

$$G_{NG} = 1 + \frac{R2}{R1}$$
(5)

For the OPAx186 circuit in 8 8-3, the results are:

$$G_{NG} = 1 + \frac{30 \text{ k}\Omega}{1 \text{ k}\Omega} = 31 \frac{\text{V}}{\text{V}}$$
$$f_{\text{H}} = \frac{750 \text{ kHz}}{31} = 24.2 \text{ kHz}$$

Make sure that the amplifier slew rate is sufficient to support the expected output voltage swing range and waveform. Also, if a single power supply (such as 24 V) is used, the ac power source applied to the sense input must have a positive dc component to keep the V_{CM} greater than 0 V. To maintain normal operation, the input voltage cannot drop to less than 0 V.

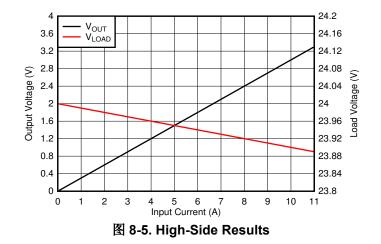
The OPAx186 output can attain a 0 V output level if a small negative voltage is used to power the V – pin instead of ground. The LM7705 is a switched capacitor voltage inverter with a regulated, low-noise, – 0.23-V fixed voltage output. Powering the OPAx186 V – pin at this level approximately matches the 300-mV linear output voltage swing lower limit, thus extending the output swing to 0 V, or very near 0 V. This configuration greatly improves the resolution at low sense current levels.

The LM7705 requires only about 78 μ A of quiescent current, but be aware that the specified supply range is 3 V to 5.25 V. The 3.3-V or 5-V supply used by the ADC can be used as a power source.

For more information about amplifier-based, high-side current monitors, see the *TI Analog Engineer* 's Circuit Cookbook: Amplifiers.

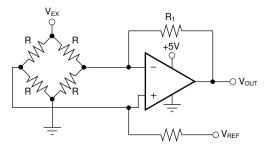


8.2.1.3 Application Curve



8.2.2 Bridge Amplifier

8-6 shows the basic configuration for a bridge amplifier. Click the following link to download the TINA-TI file: *Bridge Amplifier Circuit*.



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图 8-6. Bridge Amplifier

8.3 Power Supply Recommendations

The OPAx186 is specified for operation from 4.5 V to 24 V (± 2.25 V to ± 12 V); many specifications apply from - 40°C to +125°C.

CAUTION

Supply voltages larger than 40 V can permanently damage the device (see the *Absolute Maximum Ratings* table).

Place 0.1- μ F bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high-impedance power supplies. For more detailed information on bypass capacitor placement, see $\frac{\# 8.4}{8.4}$.



8.4 Layout

8.4.1 Layout Guidelines

For best operational performance of the device, use good PCB layout practices:

- For the lowest offset voltage, avoid temperature gradients that create thermoelectric (Seebeck) effects in the thermocouple junctions formed from connecting dissimilar conductors. Also:
 - Use low thermoelectric-coefficient conditions (avoid dissimilar metals).
 - Thermally isolate components from power supplies or other heat sources.
 - Shield operational amplifier and input circuitry from air currents, such as cooling fans.
- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and the op amp itself. Bypass capacitors reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
 - Connect low-ESR, 0.1-µF ceramic bypass capacitors between each supply pin and ground, placed as close as possible to the device. A single bypass capacitor from V+ to ground is applicable for singlesupply applications.
- Separate grounding for analog and digital portions of circuitry is one of the simplest and most effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup. Make sure to physically separate digital and analog grounds paying attention to the flow of the ground current. For more detailed information, see the *The PCB is a component of op amp design* analog application journal.
- To reduce parasitic coupling, run the input traces as far away as possible from the supply or output traces. If these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better as opposed to in parallel with the noisy trace.
- Place the external components as close as possible to the device. As 🛽 8-7 shows, keep the feedback resistor (R3) and gain resistor (R4) close to the inverting input to minimize parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- For best performance, clean the PCB following board assembly.
- Any precision integrated circuit can experience performance shifts due to moisture ingress into the plastic package. Following any aqueous PCB cleaning process, bake the PCB assembly to remove moisture introduced into the device packaging during the cleaning process. A low-temperature, post-cleaning bake at 85°C for 30 minutes is sufficient for most circumstances.



8.4.2 Layout Example

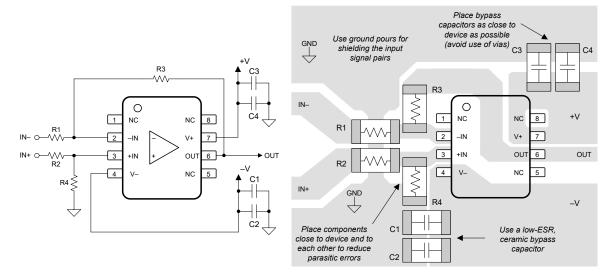


图 8-7. Operational Amplifier Board Layout for Difference Amplifier Configuration



9 Device and Documentation Support

9.1 Device Support

9.1.1 Development Support

9.1.1.1 PSpice[®] for TI

PSpice[®] for TI 是可帮助评估模拟电路性能的设计和仿真环境。在进行布局和制造之前创建子系统设计和原型解决 方案,可降低开发成本并缩短上市时间。

9.1.1.2 TINA-TI™ 仿真软件 (免费下载)

TINA-TI[™] 仿真软件是一款简单易用、功能强大且基于 SPICE 引擎的电路仿真程序。TINA-TI 仿真软件是 TINA[™] 软件的一款免费全功能版本,除了一系列无源和有源模型外,此版本软件还预先载入了一个宏模型库。TINA-TI 仿 真软件提供所有传统的 SPICE 直流、瞬态和频域分析,以及其他设计功能。

TINA-TI 仿真软件提供全面的后处理能力,便于用户以多种方式获得结果,用户可从设计工具和仿真网页免费下载。虚拟仪器提供选择输入波形和探测电路节点、电压以及波形的能力,从而构建一个动态的快速启动工具。

备注

必须安装 TINA 软件或者 TINA-TI 软件后才能使用这些文件。请从 TINA-TI™ 软件文件夹中下载免费的 TINA-TI 仿真软件。

9.2 Documentation Support

9.2.1 Related Documentation

For related documentation see the following:

- · Texas Instruments, Zero-drift Amplifiers: Features and Benefits application brief
- Texas Instruments, The PCB is a component of op amp design application note
- Texas Instruments, Operational amplifier gain stability, Part 3: AC gain-error analysis
- Texas Instruments, Operational amplifier gain stability, Part 2: DC gain-error analysis
- Texas Instruments, Using infinite-gain, MFB filter topology in fully differential active filters application note
- Texas Instruments, Op Amp Performance Analysis
- Texas Instruments, Single-Supply Operation of Operational Amplifiers application note
- Texas Instruments, Shelf-Life Evaluation of Lead-Free Component Finishes application note
- Texas Instruments, Feedback Plots Define Op Amp AC Performance application note
- · Texas Instruments, EMI Rejection Ratio of Operational Amplifiers application note
- Texas Instruments, Analog Linearization of Resistance Temperature Detectors application note
- Texas Instruments, TI Precision Design TIPD102 High-Side Voltage-to-Current (V-I) Converter

9.3 接收文档更新通知

要接收文档更新通知,请导航至 ti.com 上的器件产品文件夹。点击*订阅更新*进行注册,即可每周接收产品信息更改摘要。有关更改的详细信息,请查看任何已修订文档中包含的修订历史记录。

9.4 支持资源

TI E2E[™] 支持论坛是工程师的重要参考资料,可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解 答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者"按原样"提供。这些内容并不构成 TI 技术规范,并且不一定反映 TI 的观点;请参阅 TI 的《使用条款》。

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9.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.7 术语表

TI术语表 本术语表列出并解释了术语、首字母缩略词和定义。

10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
	(1)				,	(2)	(6)	(3)		(4,3)	
OPA186DBVR	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-2-260C-1 YEAR	-40 to 125	31CQ	Samples
OPA186DBVT	ACTIVE	SOT-23	DBV	5	250	RoHS & Green	SN	Level-2-260C-1 YEAR	-40 to 125	31CQ	Samples
OPA2186DDFR	ACTIVE	SOT-23-THIN	DDF	8	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	2MZ3	Samples
OPA2186DR	ACTIVE	SOIC	D	8	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	O2186	Samples
OPA4186DR	ACTIVE	SOIC	D	14	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 125	OPA4186	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



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PACKAGE OPTION ADDENDUM

13-Mar-2023

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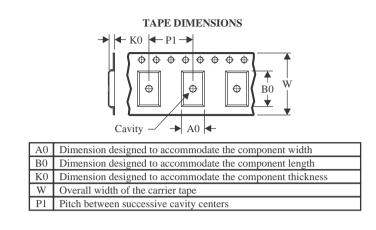


Texas

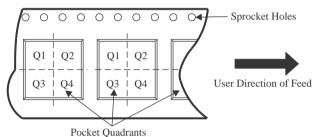
STRUMENTS

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



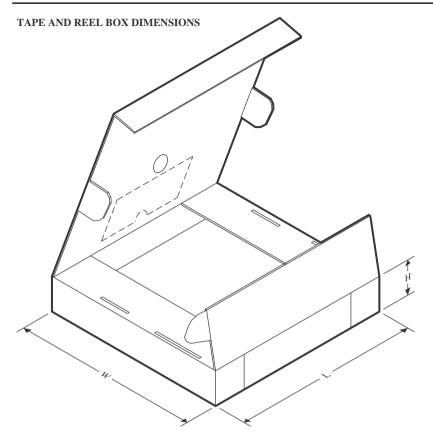
*All dimensions are nomina	<u>l</u>											
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
OPA186DBVR	SOT-23	DBV	5	3000	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
OPA186DBVT	SOT-23	DBV	5	250	178.0	9.0	3.3	3.2	1.4	4.0	8.0	Q3
OPA2186DDFR	SOT-23- THIN	DDF	8	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
OPA2186DR	SOIC	D	8	3000	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
OPA4186DR	SOIC	D	14	3000	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1



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PACKAGE MATERIALS INFORMATION

24-Dec-2022



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
OPA186DBVR	SOT-23	DBV	5	3000	190.0	190.0	30.0
OPA186DBVT	SOT-23	DBV	5	250	190.0	190.0	30.0
OPA2186DDFR	SOT-23-THIN	DDF	8	3000	210.0	185.0	35.0
OPA2186DR	SOIC	D	8	3000	356.0	356.0	35.0
OPA4186DR	SOIC	D	14	3000	356.0	356.0	35.0

DBV0005A



PACKAGE OUTLINE

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. Refernce JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



DBV0005A

EXAMPLE BOARD LAYOUT

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DBV0005A

EXAMPLE STENCIL DESIGN

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



D0008A



PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.

- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



D0008A

EXAMPLE BOARD LAYOUT

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



D0008A

EXAMPLE STENCIL DESIGN

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.



DDF0008A



PACKAGE OUTLINE

SOT-23 - 1.1 mm max height

PLASTIC SMALL OUTLINE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.



DDF0008A

EXAMPLE BOARD LAYOUT

SOT-23 - 1.1 mm max height

PLASTIC SMALL OUTLINE



4. Publication IPC-7351 may have alternate designs.

5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DDF0008A

EXAMPLE STENCIL DESIGN

SOT-23 - 1.1 mm max height

PLASTIC SMALL OUTLINE



6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

7. Board assembly site may have different recommendations for stencil design.



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